TOSHIBA Power Transistor Module Silicon NPN Triple Diffused Type (Darlington power transistor 4 in 1)

MP4513

High Power Switching Applications.

Hammer Drive, Pulse Motor Drive and Inductive Load Switching.

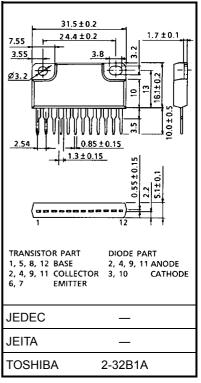
- Package with heat sink isolated to lead (SIP 12 pin)
- High collector power dissipation (4 devices operation)
 PT = 5 W (Ta = 25°C)
- High collector current: IC (DC) = 5 A (max)
- High DC current gain: hFE = 1000 (min) (VCE = 3 V, IC = 3 A)
- Diode included for absorbing fly-back voltage.

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Collector-base voltage		V_{CBO}	100	V	
Collector-emitter voltage		V _{CEO}	100	V	
Emitter-base voltage		V _{EBO}	5	V	
Collector current	DC	I _C	5	Α	
	Pulse	I _{CP}	8	A	
Continuous base current		Ι _Β	0.1	Α	
Collector power dissipation (1 device operation, Ta = 25°C)		P _C	3.0	W	
Collector power dissipation	Ta = 25°C	P _T	5.0	W	
(4 devices operation)	Tc = 25°C		25	VV	
Isolation voltage		V _{Isol}	1000	V	
Junction temperature		Tj	150	°C	
Storage temperature range		T _{stg}	-55 to 150	°C	

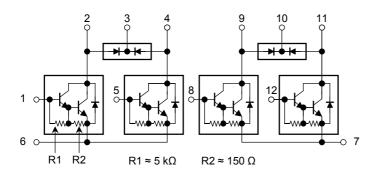
Industrial Applications

Unit: mm



Weight: 6.0 g (typ.)

Array Configuration





Thermal Characteristics

Characteristics	Symbol	Max	Unit	
Thermal resistance of junction to ambient (4 devices operation, Ta = 25°C)	ΣR _{th (j-a)}	25	°C/W	
Thermal resistance of junction to case (4 devices operation, Tc = 25°C)	ΣR _{th (j-c)}	5.0	°C/W	
Maximum lead temperature for soldering purposes (3.2 mm from case for 10 s)	TL	260	°C	

Electrical Characteristics (Ta = 25°C)

Charac	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off cu	rrent	I _{CBO}	V _{CB} = 100 V, I _E = 0 A	_	_	10	μΑ
Collector cut-off cu	rrent	I _{CEO}	V _{CE} = 100 V, I _B = 0 A	-	-	10	μΑ
Emitter cut-off curre	ent	I _{EBO}	V _{EB} = 5 V, I _C = 0 A	0.3	-	2.0	mA
Collector-base brea	akdown voltage	V (BR) CBO	I _C = 1 mA, I _E = 0 A	100	-	_	V
Collector-emitter bi	reakdown voltage	V (BR) CEO	I _C = 30 mA, I _B = 0 A	100	-	_	V
DC current gain	h _{FE (1)}	V _{CE} = 3 V, I _C = 0.5 A	1000	_	_	_	
	h _{FE (2)}	V _{CE} = 3 V, I _C = 3 A	1000	_	_		
Saturation voltage	Collector-emitter	V _{CE} (sat)	I _C = 3 A, I _B = 12 mA	_	_	2.0	V
	Base-emitter	V _{BE (sat)}	I _C = 3 A, I _B = 12 mA	_	_	2.5	
Transition frequence	cy .	f _T	V _{CE} = 3 V, I _C = 0.5 A	_	10	_	MHz
Collector output capacitance		C _{ob}	V _{CB} = 10 V, I _E = 0 A, f = 1 MHz	_	40	_	pF
Switching time Storage time Fall time	t _{on}	Output Input	_	0.5	_		
	Storage time	t _{stg}	20 μs B2 W S C C S C C C C C C	_	4.0	_	μs
	Fall time	t _f		_	2.5	_	

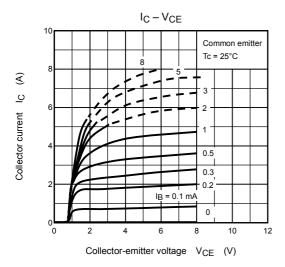
Emitter-Collector Diode Ratings and Characteristics (Ta = 25°C)

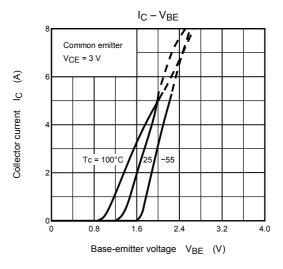
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Forward current	I _{FM}	_	_	_	5	Α
Surge current	I _{FSM}	t = 1 s, 1 shot	_	_	8	Α
Forward voltage	V _F	I _F = 1 A, I _B = 0 A	_	1.1	1.8	V
Reverse recovery time	t _{rr}	I _F = 5 A, V _{BE} = -3 V, dI _F /dt = -50 A/μs	_	3.0	_	μs
Reverse recovery charge	Q _{rr}		_	40	_	μC

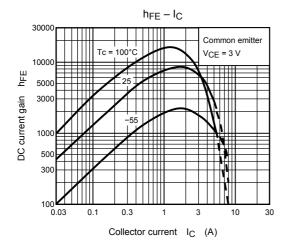
Flyback-Diode Rating and Characteristics (Ta = 25°C)

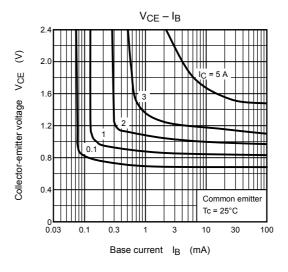
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Forward current	I _{FM}	_	_	_	3	Α
Reverse current	I _R	V _R = 100 V	_	_	0.4	μA
Reverse voltage	V_{R}	I _R = 100 μA	100	_	_	V
Forward voltage	V _F	I _F = 1 A	_	_	1.8	V

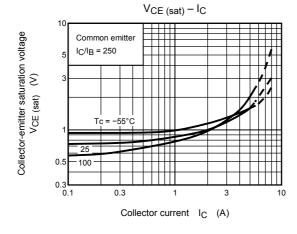
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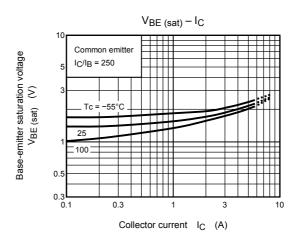


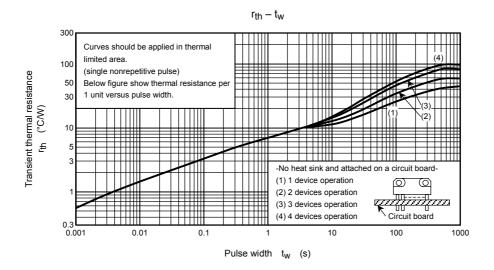


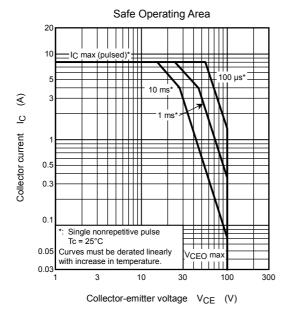


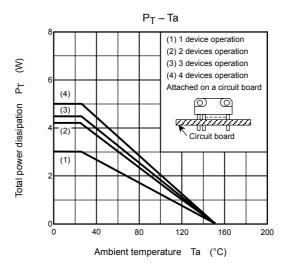


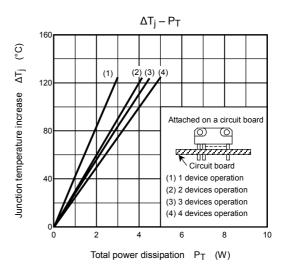












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